

Search Notes

Application/Control No.

10/500,788

Examiner

Son T. Nguyen

Applicant(s)/Patent under
Reexamination

HALACHMI ET AL.

Art Unit

3643

SEARCHED

Class	Subclass	Date	Examiner
119	14.02 14.08	5/3/2006	STN
	14.18 712		
	51.02 856		
	858 908		
	14.47 720		
	721		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
IPC foreign search: A01J 5/00,5/007, 5/017; A01K 15/02,27/00	5/3/2006	STN
text search, see printouts	5/3/2006	STN